## Notice of References Cited Application/Control No. 09/747,871 Examiner Thu V Huynh Applicant(s)/Patent Under Reexamination DAVIS ET AL. Page 1 of 1

IDC-US Ref-10 **U.S. PATENT DOCUMENTS Document Number** Date Country Code-Number-Kind Code Name Classification **MM-YYYY** US-2002/0010711 01-2002 NAKANISHI et al. 707/501.1 US-2002/0026461 02-2002 Kutay et al. 707/523 US-20040210556 10-2004 С Brooke et al. 707/1 US-20040205528 Q2-2004 Alexander 715/505 US-2002/0023113 02-2002 Hsing et al. 707/513 F US-6,578,000 06-2003 Dodrill et al. 704/270 G US-2002/0099738 07-2002 Grant, Hugh Alexander 707/513 н US-6,732,331 05-2004 Alexander, Vlad 715/513 US-2001/0044811 11-2001 Ballantyne et al. 707/513 J US-2002/0143821 10-2002 Jakubowski, Douglas 707/522 US-Κ US-US-

## **FOREIGN PATENT DOCUMENTS**

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